# Dual P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (mΩ) (Max.)	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)			
- 20	16 at V <sub>GS</sub> = - 4.5 V	- 10 <sup>a</sup>	19.5 nC			
20	19 at V <sub>GS</sub> = - 2.5 V	] - 10	19.5 110			

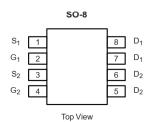
#### **FEATURES**

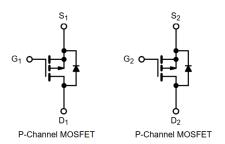
- DT-Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested

#### **APPLICATIONS**

- MB / VGA / Vcore
- POL Applications
- Networking







ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)						
Parameter		Symbol	Limit	Unit		
Drain-Source Voltage	V <sub>DS</sub>	- 20	V			
Gate-Source Voltage		$V_{GS}$	V <sub>GS</sub> ± 12			
	T <sub>C</sub> = 25 °C		- 10 <sup>a</sup>			
Continuous Drain Current (T <sub>1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		- 6 <sup>a</sup>			
Continuous Brain Current (1) = 100 O)	T <sub>A</sub> = 25 °C	ID	- 3 <sup>b, c</sup>			
	T <sub>A</sub> = 70 °C		- 1.2 <sup>b, c</sup>	Α		
Pulsed Drain Current (t = 300 μs)		I <sub>DM</sub> - 40				
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	- I <sub>S</sub>	- 10 <sup>a</sup>			
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	'S	- 3 <sup>b, c</sup>			
	T <sub>C</sub> = 25 °C		11	W		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	7			
Maximum r ower Dissipation	$T_A = 25 ^{\circ}C$	, n	2.5 <sup>b, c</sup>			
	T <sub>A</sub> = 70 °C		1.6 <sup>b, c</sup>			
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature		260				

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b, e</sup>	t ≤ 5 s	$R_{thJA}$	45	62	°C/W
Maximum Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	4.0	5.5	5/ • • •

#### Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- e. Maximum under steady state conditions is 80 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	- 20			V	
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = - 250 μA		- 10		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 <sub>D</sub> = - 230 μΛ		2.8			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.3		- 1.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	1	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V			- 1		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			- 10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 4.5 V	-10			Α	
Dunin Course On State Besistance	Rear )	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 4 A		16	19	<u> </u>	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 3 A		19	25		
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 3 A		9		S	
Dynamic <sup>b</sup>		'		·	<b>'</b>	<b>'</b>	
Input Capacitance	C <sub>iss</sub>			1370			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		203		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			100			
Total Gate Charge	Qq			19.5			
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4 \text{ A}$		3		nC	
Gate-Drain Charge	Q <sub>gd</sub>			5		1	
Gate Resistance	R <sub>g</sub> f = 1 MHz			5		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10			
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, R_{L} = 0.75 \Omega$		12			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = -4 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		20			
Fall Time	t <sub>f</sub>			27		]	
Turn-On Delay Time	t <sub>d(on)</sub>			20		ns	
Rise Time	t <sub>r</sub>	V <sub>DD</sub> = - 10 V, R <sub>L</sub> = 0.75 Ω		32			
Turn-Off Delay Time	$t_{d(off)}$ $I_D = -3 \text{ A}, V_{GEN} = -2.5 \text{ V}, R_g = 1 \Omega$			42			
Fall Time	t <sub>f</sub>			30		1	
<b>Drain-Source Body Diode Characterist</b>	ics						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 10	Α	
Pulse Diode Forward Current	I <sub>SM</sub>				40		
Body Diode Voltage V <sub>SD</sub>		I <sub>S</sub> = -1 A, V <sub>GS</sub> = 0 V			- 1	V	
Body Diode Reverse Recovery Time t <sub>rr</sub>				40		ns	
Body Diode Reverse Recovery Charge Q <sub>rr</sub>		I <sub>F</sub> = - 10 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C -		20		nC	
Reverse Recovery Fall Time t <sub>a</sub>		- 1 - 10 Λ, αναι - 100 Λ/μο, 1 - 25 0		14		ne	
Reverse Recovery Rise Time	t <sub>b</sub>			16		ns	

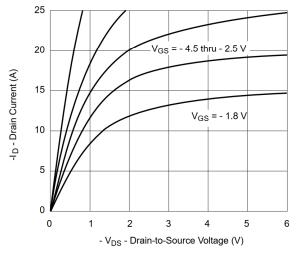
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

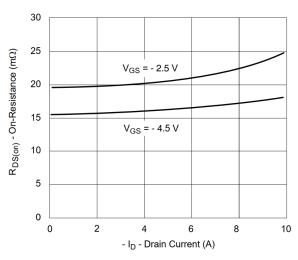
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.



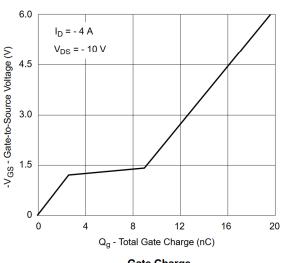
#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



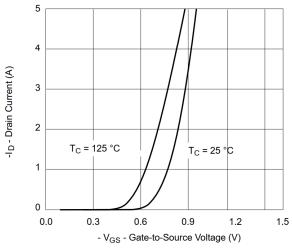
#### **Output Characteristics**



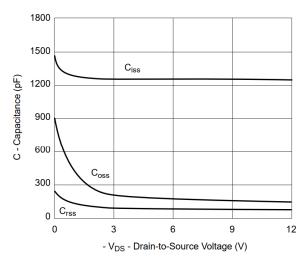
#### On-Resistance vs. Drain Current and Gate Voltage



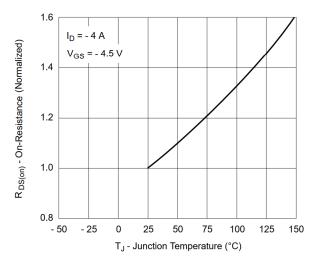
**Gate Charge** 



**Transfer Characteristics** 



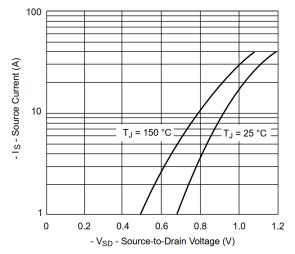
Capacitance



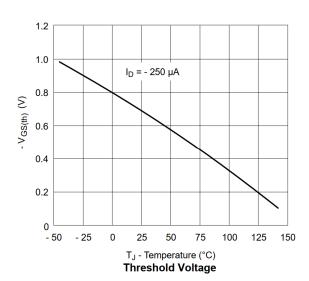
On-Resistance vs. Junction Temperature

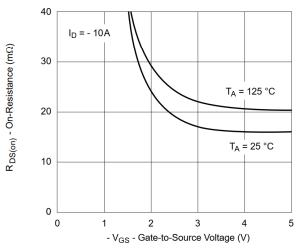


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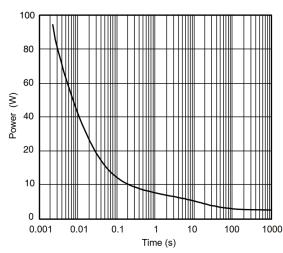


#### Soure-Drain Diode Forward Voltage

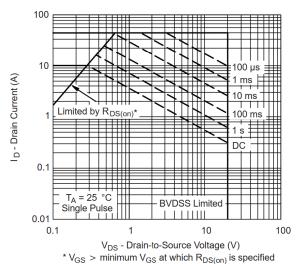




On-Resistance vs. Gate-to-Source Voltage



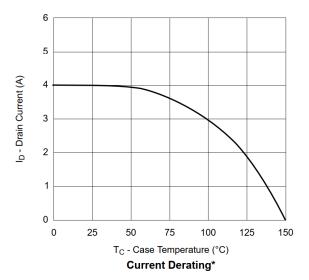
Single Pulse Power, Junction-to-Ambient

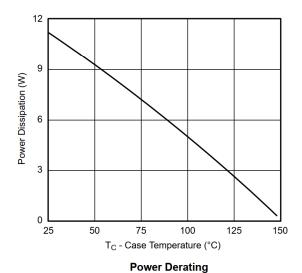


Safe Operating Area, Junction-to-Ambient



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

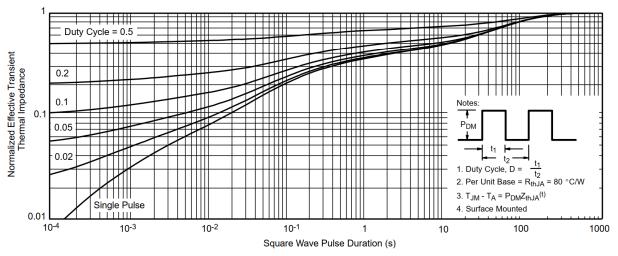




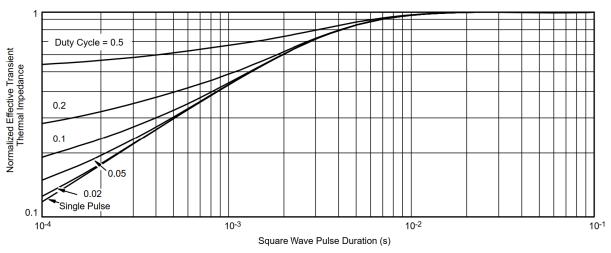
<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)}$  = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



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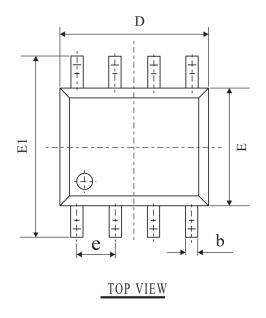
Normalized Thermal Transient Impedance, Junction-to-Ambient

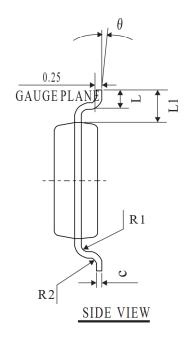


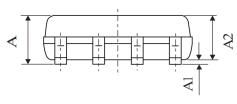
Normalized Thermal Transient Impedance, Junction-to-Case



## **SOP-8 PACKAGE OUTLINE**







SIDE VIEW

COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX		
A	1.30	1.60	1.85		
A1	0.03	0.15	0.28		
A2	1.20	1.45	1.70		
ь	0.26	0.40	0.54		
С	0.132	0.203	0.273		
D	4.50	4.90	5.30		
Е	3.50	3.00	4.30		
E1	5.50	6.00	6.50		
L	0.30	30 0.70 1.10			
θ	2° 4° 6°				
L1	1.04REF				
e	1.27BSC				
R1	0.07TYP				
R2	0.07TYP				

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